



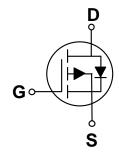
General Description

The P5MPM050 uses advanced trench MOSFET technology to provide excellent $R_{\rm DS(ON)}$ and gate charge for use in a wide variety of other applications. The P5MPM050 meets the RoHS and Green Product requirement with full function reliability approved.

BV _{DSS}	R _{DS(ON)}	I_D
-100 V	50 mΩ	-8 A

PPAK5X6 Pin Configuration





Features

- -100V, -8A, $R_{DS(ON)}$ =50m Ω @ V_{GS} = -10V
- · Super Low Gate Charge
- · Green Device Available
- · Excellent CdV/dt effect decline

bsolute Maximum Ratings T _C =25°C unless otherwise noted						
Symbol	Parameter	Rating	Units			
V_{DS}	Drain-Source Voltage	-100	V			
V_{GS}	Gate-Source Voltage	±20	V			
1	Drain Current - Continuous, V _{GS} @-10V (NOTE 1) (T _A =25°C)	-8	Α			
I _D	Drain Current - Continuous, V _{GS} @-10V (NOTE 1) (T _A =100°C)	-6.5	Α			
I _{DM}	Drain Current - Pulsed (NOTE 2)	-45	Α			
EAS	Single Pulse Avalanche Energy (NOTE 3)	345	mJ			
IAS	Avalanche Current	28	Α			
P_{D}	Total Power Dissipation (T _A =25°C) (NOTE 4)	5.5	W			
T _J	Operating Junction Temperature Range	-50 to 150	°C			
T _{STG}	Storage Temperature Range	-50 to 150	°C			
Marking Code		PM050 / A0139				

Thermal Characteristics					
Symbol	Parameter	Тур.	Max.	Unit	
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (NOTE 1)		62	°C/W	
$R_{ heta JC}$	Thermal Resistance Junction to Case (NOTE 1)		1.22	°C/W	





Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V , I_D = -250uA	-100			V
I _{DSS}	Drain-Source Leakage Current	V_{DS} = -100V , V_{GS} = 0V , T_{J} =25 $^{\circ}$ C			-50	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = ±20V , V_{DS} = 0V			±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} = -10V , I_D = -8A		42	50	mΩ
NDS(ON)	(NOTE 2)	V_{GS} = -4.5V , I_{D} = -6A		46	55	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=-250uA$	-1.2	-1.8	-2.5	V
gfs	Forward Transconductance	$V_{DS} = -10V$, $I_{D} = -10A$		32		S

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Q_g	Total Gate Charge	V = 90V V = 10V		92		
Q_{gs}	Gate-Source Charge	V _{DS} = -80V , V _{GS} = -10V , I _D = -8A		17.5		nC
Q_{gd}	Gate-Drain Charge			14		i
$T_{d(on)}$	Turn-On Delay Time			20.5		
T _r	Rise Time	V_{DD} = -50V , V_{GS} = -10V , R_{G} = 3.3 Ω , I_{D} = -1A		32.2		nS
$T_{d(off)}$	Turn-Off Delay Time			123		113
T _f	Fall Time			63.7		
C _{iss}	Input Capacitance	V _{DS} = -25V , V _{GS} = 0V , F= 1MHz		6516		
C _{oss}	Output Capacitance			223		pF
C _{rss}	Reverse Transfer Capacitance			125		

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current (NOTE1 \ 5)	$V_G = V_D = 0V$, Force Current			-30	Α
V_{SD}	Diode Forward Voltage (NOTE 2)	V _{GS} = 0V , I _S = -1A , T _J =25°C			-1.2	V
trr	Reverse Recovery Time	I _F =-14A , di/dt=-100A/μs ,		31.2		nS
Qrr	Reverse Recovery Charge	T _J =25°C		31.97		nC

NOTES:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2oz copper.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. The EAS data shows Max. rating. The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.88mH, I_{AS} =-28A.
- 4. The power dissipation is limited by 150°C junction temperature.
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





Characteristics Curves

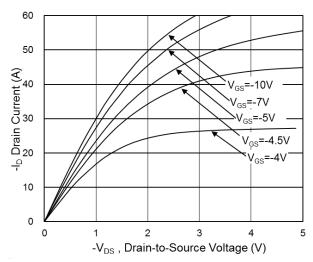


Fig.1 Typical Output Characteristics

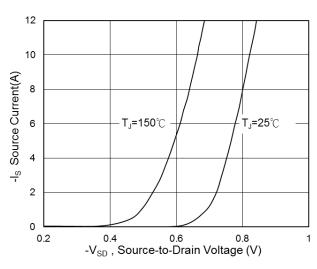


Fig.3 Typical S-D Diode Forward Voltage

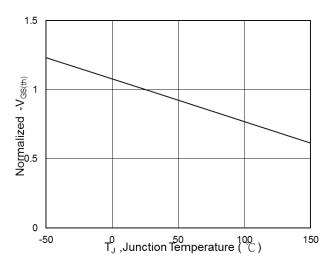


Fig.5 Normalized V_{GS(th)} vs T_J

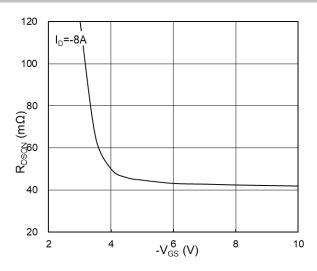


Fig.2 On-Resistance vs G-S Voltage

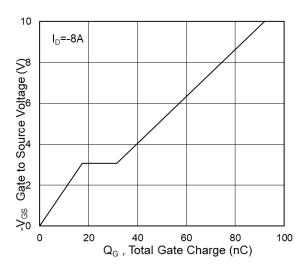


Fig.4 Gate-Charge Characteristics

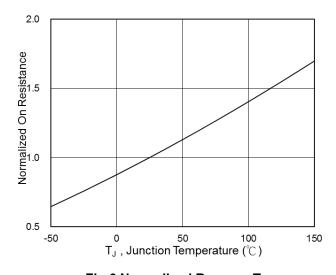
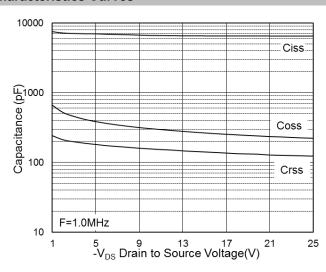


Fig.6 Normalized R_{DSON} vs T_{J}





Characteristics Curves



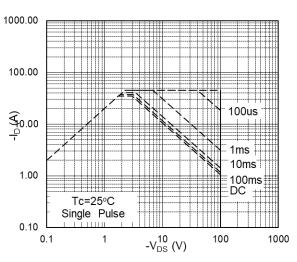


Fig.7 Capacitance

Fig.8 Safe Operating Area

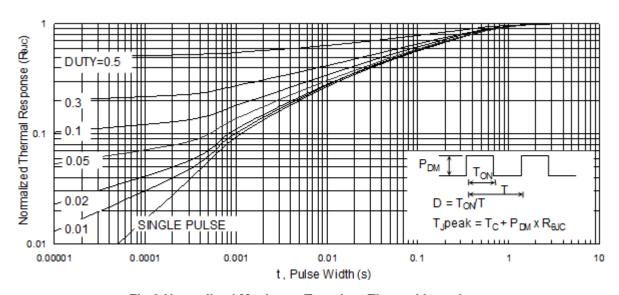
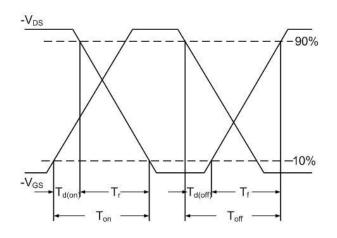


Fig.9 Normalized Maximum Transient Thermal Impedance



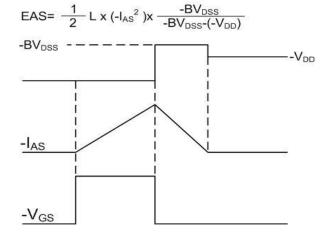


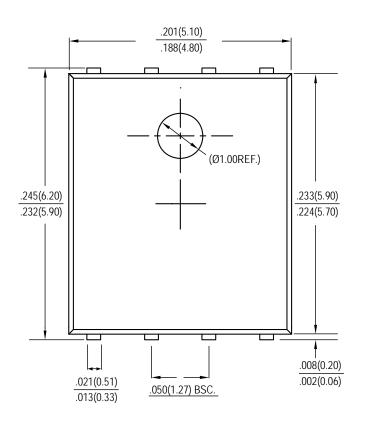
Fig.10 Switching Time Waveform

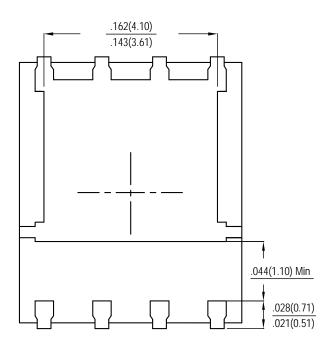
Fig.11 Unclamped Inductive Waveform

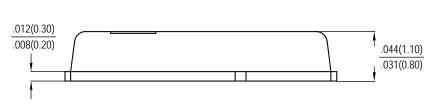


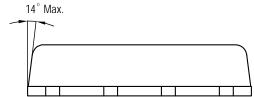


Package Outline Dimensions









PPAK5X6

Dimensions in inches and (millimeters)





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